TOSHIBA CMOS DIGITAL INTEGRATED CIRCUIT SILICON MONOLITHIC

# T9947S, JT9947X-AS

# T9947S, JT9947X-AS CMOS 1 CHIP LSI FOR LCD ELECTRONIC **CALCULATOR**

The T9947S, JT9947X-AS is a 1 chip microcomputer for 10-digits 1-memory electronic calculator. T9947S, JT9947X-AS can drive the liquid crystal display (LCD). Single power supply operation, low power consumption make it suitable for solar battery or battery operated pocketable calculator.

### **FEATURES**

- 10 digits of data and 1 symbol digit for calculator.
- Algebraic calculation mode.
- Punctuation.
- Standard 4 functions  $(+, -, \times, \div)$ , square root, percent with automatic add-on/discount, automatic constant calculations, chain calculations, memory calculations with memory overflow protection.
- Internal keyboard decoding and denouncing.
- Complementary output buffer for direct driving of liquid crystal display (LCD : FEM type −3.0V, 1/2 bias, 1/3 duty).
- Single power supply ( 1.5V typ.).
- Quad in line flat package (60 PIN).
- Very low power consumption (3.0  $\mu$ W typ. at wait) .
- Very wide range of operating voltage ( $V_{SS1} = -1.2 \sim -2.0 \text{V}$ ).

# LQFP60-P-1414-0.80

Weight: 0.66g (Typ.)

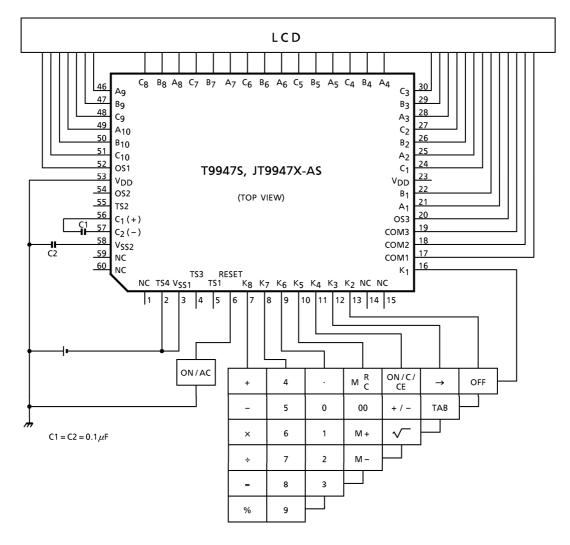
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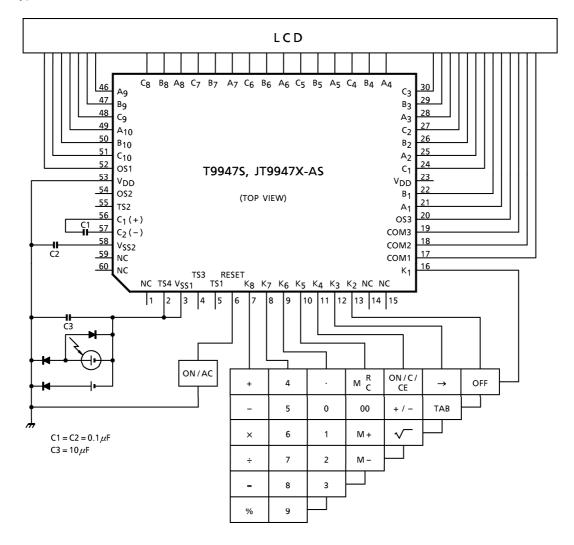
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### SYSTEM BLOCK DIAGRAM

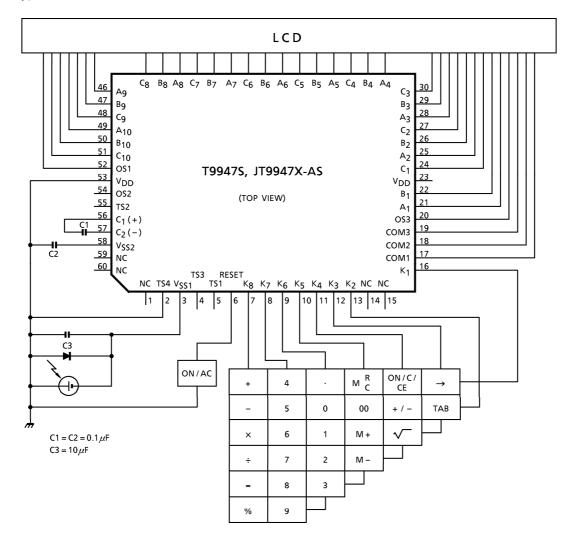
### **Battery Type**



### **Dual Type**

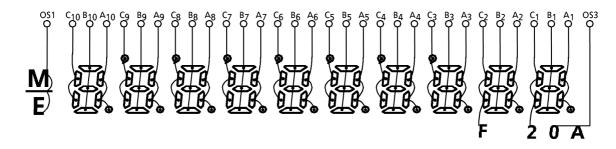


### Solar Type

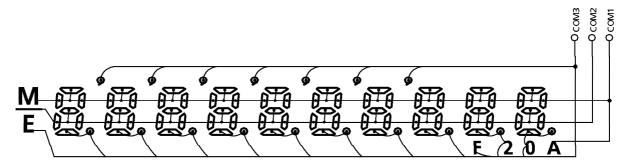


### **CONNECTION OF LCD**

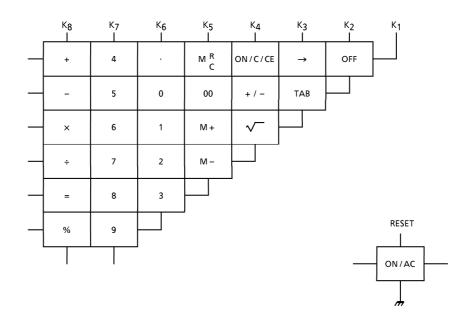
**SEGMENT** 



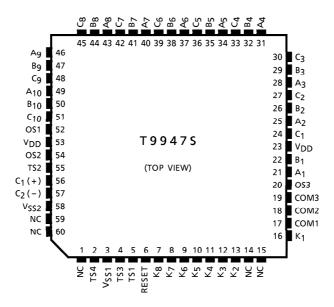
COMMON



### **KEY LAYOUT**



### **PIN LAYOUT**



### SPECIFICATION OF CALCULATOR

### **Operational Features**

- (1) 10 digits of data and 1 symbol digit.
- (2) Algebraic mode.
- (3) Full floating point.
- (4) Standard 4 functions +, -,  $\times$ ,  $\div$ .
- (5) Memory calculation.
- (6) Square root.
- (7) Percent with automatic add-on and discount.
- (8) Constant calculation (Automatic constant).
- (9) Chain calculation.
- (10) Leading zero suppression.
- (11) Trailing zero suppression.

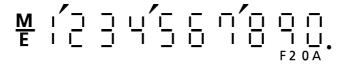
### Capacity of Calculation

(1)	Numeral	entry	10 digits
-----	---------	-------	-----------

(2) Addition / Subtraction
 (3) Multiplication / Division
 (4) Memory calculation
 10 digits + (-) 10 digits = 10 digits
 (4) digits + (-) 10 digits = 10 digits

(5) Square root  $\sqrt{10}$  digits = 10 digits

### Display Font



### **Overflow Condition**

- (1) When division by zero is attempted, an overflow condition will result, and error symbol "E" and a zero are displayed.
- (2) When the integer part of result exceeds 10 digits, the display will show 10 most significant digits of result divided by 10<sup>+10</sup> and "E".
- (3) When the integer part of result exceeds 19 digits, display will show a zero and "E".
- (4) When the integer part of result in memory register exceeds 10 digits at memory calculation, display will show a zero and "E", and previous data will be kept in memory resister.
- (5) When an overflow occurs on the way of add-on/discount calculation, display will show a zero and "E".
- (6) When square root of any negative number is attempted, "E" and square root of absolute value are displayed.
- (7) In overflow condition, any operation or numeral entry will be inhibited.

### Clearing Overflow Condition

- (1) The resulting overflow condition can be cleared by depressing ON/C/CE .
- (2) At memory overflow condition, depression of  $M_C^R$  after ON/C/CE will recall the previous memory data.
- (3) At the condition of exceeding capacity overflow occurred in chain calculation, depression of ON/C/CE will reset the error symbol "E", and you can continue the calculation using the displayed data.

### Speed of Calculation

(1)	Numeral entry				74.4ms
(2)	Addition	1111111111 +	1111111111	=	102.7ms
(3)	Multiplication	1 ×	9999999999	=	394.7ms
(4)	Division	999999999 ÷	1	=	394.7ms
(5)	Memory calculation	999999999 ÷	1	M +	482.7ms
(6)	Percentage calculation	1 +	9999999999	%	378.7ms
(7)	Square root		999999999	$\sqrt{}$	326.7ms

### **Keys for Calculator**

(1) Data Keys

The data keys consist of numeral keys 0,00 through 9 and a decimal point key . The first of a sequence of data keys will clear the contents of display register before being entered. The decimal point key will be accepted the first time it is depressed during calculations.

(2) Arithmetic Operation Keys

The arithmetic operation keys include the plus +, minus -, multiply  $\times$ , divide  $\div$ , equal =, percent %, square root  $\sqrt{\phantom{M}}$ , memory add  $\boxed{M+}$ , memory subtract  $\boxed{M-}$ , sign change  $\boxed{+/-}$ , data shift  $\Longrightarrow$ .

+ Depression of this key conditions the calculator for addition of display register to upper register.

If the calculator was previously conditioned for add, subtract, multiply or device, those operation would be performed with the resultant intermediate sum, difference, product or quotient displayed and previous modes and reset, and calculator stores add command.

In the successive depressions of this key, the first will perform the previously enabled mode and more than twice depressions will be ignored.

- Depression of this key performs the same function as the + key with the exception that calculator stores subtract mode.
- Depression of this key conditions the calculator for multiplication of upper register and display register.

If the calculator was previously conditioned for add, subtract multiply or divide, those operation would be performed with the resultant intermediate sum, difference, product or quotient displayed.

And then set the multiply mode.

- M Depression of this key will perform the same function as the M + with the exception that the calculator result or displayed number is subtracted from the memory register.
- Depression of this key following numeral entry will perform the previously enabled mode.

If no number has been entered, the displayed number will be used to perform the previously enabled mode. If no mode are enabled, this key will be ignored. If multiplication or division are enabled, constant mode operations are performed by termination a sequence of operations with the = key, entering a new number and depressing the = key.

Any key sequence terminated with,  $\equiv$  key will not require the use of  $\boxed{\text{ON/C/CE}}$  key before a new operation sequence can be initiated.

If the calculator was previously conditioned for addition, or subtraction or multiplication or divination, [%] calculations would be performed as follows.

$$a + b | \% | a + a \cdot b / 100$$

a – b 
$$\overline{\%}$$
 a – a·b / 100

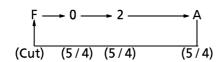
If no mode are enabled, this key will be ignored. If multiplication or division are enabled, constant mode operations are performed by terminating a sequence of operation with the \( \frac{\infty}{\infty} \) key, entering new number and depressing the \( \frac{\infty}{\infty} \) key.

M+ Depression of this key will perform the previously enabled mode and add the result to memory register and leave the result in the display register.

If no modes are enabled, the displayed number is added to memory register by this key.

Any key sequence terminated with  $\boxed{M+}$  will not require the use of the  $\boxed{ON-/C-/CE}$  key before a new operation sequence can be initiated.

TAB "TAB" fixed point mode selectable



Depression of this key performs a similar function as the x key except that division of upper register by display register is either set up or performed and the divide mode is activated.

		Depression of this key calcular changing modes of operation Depression of this key follow of display register to upper redisplayed.  The entry of a new number of the calculation of this key calculation of the calculation of this key calculation of the calculat	i. $+$ , $-$ , $\times$ , or $+$ egister and calculate th	keys will transfer the contents e square root of number
	+/-	Depression of this key will ch	ange the sign of displa	y register.
	$\rightarrow$	Depression of this key will sh	ift the right data of di	splay register.
(3)	Comm	and Function Keys		
	The co	mmand function keys include	the clear entry/clear a	II ON/C/CE , recall/clear
	мR	Depression of this key for of display register to up to display register.  MR key following = , contents of memory register other operations in programmes of the pression of this key and display register.	per register and recall $M$ , $M+$ , $M-$ or any ister to the display regions.  If $M_C^R$ key will clear the fter $M_C^R$ , $\sqrt{}$ , $0$ , or symbol "E" if you depress.	
	OFF	Depression of this key w	vill off the LSI.	
Arithme	tic Oper	ations		
1. A	ddition		Key Op.	Display
			Α	Α
			+	Α
			В	В
			+	A + B
			С	С

=

D +

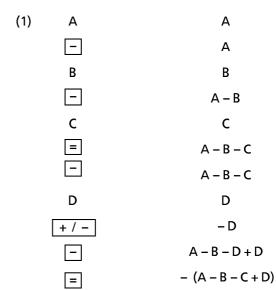
Ε

A + B + CD

D

Ε

### 2. Subtraction



### 3. Multiplication

(1)	Α	Α
	×	А
	В	В
	=	A∙B
	+	A∙B
	С	С
	=	A⋅B + C
(2)	_	0.
	Α	А
	×	- A
	В	В
	=	- A·B

		Key Op.	Display
4. Division			
	(1)	Α	Α
		÷	Α
		В	В
		=	A/B
	(2)	-	0.
		Α	Α
		÷	- A
		В	В
		=	- A / B
5. Power calculation			
	(1)	Α	Α
		×	Α
		=	$A^2$
		=	$A^3$
	(2)	Α	Α
		÷	Α
		=	1/A
		=	$1/A^2$
	(3)	-	0.
		Α	Α
		×	- A
		=	$A^2$
		=	- A <sup>3</sup>
	(4)	-	0.
		Α	Α
		÷	- A
		=	-1/A
		=	$1/A^2$

	Key Op.	Display
(5)	Α	Α
	×	А
	=	$A^2$
	×	$A^2$
	=	$A^4$

### 6. Mixed calculation

(1)	Α	Α
	×	Α
	В	В
	+	A∙B
	C	C
	÷	A·B + C
	D	D
	_	$\frac{A \cdot B + C}{D}$
	E	E
	=	$\frac{A \cdot B + C}{D} - E$

Α

### 7. Constant calculation

	×	Α
	В	В
	=	A·B
	C	C
	=	A·C
(2)	_	0.
	Α	Α
	×	- A
	В	В
	=	– A∙B
	C	C

(1) A

	Key Op.	Display
	=	– A·C
(3)	Α	А
	÷	А
	В	В
	=	A/B
	С	С
	=	C/B
	D	D
	×	D
	=	$D^2$
(4)	Α	А
	+	А
	В	В
	=	A + B
	С	С
	=	С
(5)	Α	А
	_	А
	В	В
	=	A – B
	С	C
	=	C
(6)	Α	А
	×	А
	В	В
	=	A∙B
	С	С
	×	С
	D	D

8. Mark-up/Discount calculator

	Key Op	. Display
	=	C∙D
	Ε	E
	=	C∙E
	×	C∙E
	F	F
	=	C·E·F
	G	G
	÷	G
	Н	Н
	=	G/H
	I	I
	=	I/H
(7)	Α	А
	×	А
	В	В
	%	A·B / 100
	C	C
	%	A·C / 100
	D	D
	÷	D
	Е	E
	%	100·D / E
	F	F
	%	100·F / E
(1)	۸	٨
(1)	A	A
	×	A
	B +	В
		A·B
		A + A·B

	Key Op.	Display
(2)	Α	А
	×	А
	В	В
	_	A·B
	=	A – A·B
(3)	Α	А
	×	А
	В	В
	%	A·B / 100
	+	A·B / 100
	=	A + A·B / 100
(4)	Α	А
	×	А
	В	В
	%	A·B / 100
	_	A·B / 100
	=	A – A·B / 100
(5)	Α	А
	+	А
	В	В
	%	A + A·B / 100
(6)	Α	А
	_	А
	В	В
	%	A – A·B / 100
	Display	Memory

## 9. Memory calculation

Key Op.	Display	Memory
(1) A	Α	0.
M +	A (M)	А
В	B (M)	Α

	Key Op.	Display	Memory
	M +	B (M)	A + B
	С	C (M)	APB
	M –	C (M)	A + B - C
	D	D (M)	A + B - C
	МR	A + B - C (M)	A + B – C
	м <sup>R</sup>	A + B - C	0.
(2)	A	А	0.
	+	Α	0.
	В	В	0.
	M +	A + B (M)	A + B
	+	A + B (M)	A + B
	M +	A + B (M)	2 (A + B)
	С	C (M)	2 (A + B)
	M –	C (M)	2 (A + B) - C
(3)	Α	А	0.
	×	Α	0.
	В	В	0.
	M +	A·B (M)	A·B
	С	C (M)	A·B
	×	C (M)	A·B
	D	D (M)	A·B
	M –	C·D (M)	A·B – C·D
	МR	$A \cdot B - D \cdot D (M)$	A·B – C·D
	M –	A·B − C·D	0.
(4)	Α	А	0.
	×	А	0.
	В	В	0.
	=	A∙B	0.
	С	С	0.
	M +	C (M)	С

Key Op.	Display	Memory
=	A·C (M)	C
D	D (M)	C
M –	D (M)	C – D
=	A·D (M)	C – D
(5) A	Α	0.
M +	A (M)	А
В	B (M)	А
M +	B (M)	A + B
M R	A + B (M)	A + B
<u>×</u>	A + B (M)	A + B
МR	A + B (M)	A + B
+	$(A + B)^2 (M)$	A + B
C	C (M)	A + B
=	$(A + B)^2 + C (M)$	A + B
(6) 1.000000001	1.00000001	0.
M +	1.00000001 (M)	1.000000001
999999999	999999999. (M)	1.000000001
M +	0. ( <mark>M</mark> )	1.000000001
ON/C/CE	0. (M)	1.000000001
M R	1.000000001 (M)	1.000000001
(1) A	А	
<b>√</b>	$\sqrt{A}$	

10. Square root

	Key Op.	Display	Memory
(3)	Α	Α	
	×	Α	
	<b>√</b>	$\sqrt{A}$	
	В	В	
	=	A∙B	
(4)	_	0.	
	Α	Α	
	=	<b>-</b> A	
	<b>√</b>	$\sqrt{A}$ (E)	
(5)	Α	Α	0.
	M +	A (M)	А
	M R	A (M)	Α
	÷	A (M)	А
	В	B (M)	А
	+ / -	– B (M)	А
	<b>√</b>	$\sqrt{B}$ ( $^{M}_{E}$ )	А
	ON/C/CE	0. (M)	Α
11.Percentage calculation	า		
(1)	Α	А	
	×	Α	
	В	В	
	%	A·B / 100	
	C	С	
	%	A·C / 100	
	D	D	
	%	A·D / 100	
(2)	Α	А	
	%	А	
	В	В	

		Key Op.	Display	Memory
		%	В	
		C	C	
		%	C	
	(3)	Α	Α	
		_	Α	
		В	В	
		%	A – A·B / 100	
		_	A – A·B / 100	
		+	A – A·B / 100	
		C %	$\left(A - \frac{A \cdot B}{100}\right) + \frac{C}{\left(A - \frac{A \cdot B}{100}\right) \cdot C}$	
12.Key correction			\	
	(1)	Α	Α	0.
		×	Α	0.
		÷	А	0.
		÷ - +	А	0.
		+	А	0.
		$\sqrt{}$	$\sqrt{A}$	0.
		M +	$A + \sqrt{A}(M)$	$A + \sqrt{A}$
		+ / -	$-(A+\sqrt{A})(M)$	$A + \sqrt{A}$
		МR	$A + \sqrt{A}(M)$	$A + \sqrt{A}$
		M R	$A + \sqrt{A}$	0.
		В	В	0.
		+	В	0.
		_	В	0.
		×	В	0.
		÷	В	0.
		=	1 / B	0.

13. Others		Key Op.	Display	Memory
	(1)	Α	Α	
		+	Α	
		=	Α	
	(2)	Α	А	
		×	А	
		÷	А	
		=	1/A	
	(3)	Α	А	
		%	А	
		+	А	
		=	А	
	(4)	Α	А	
		×	Α	
		_	Α	
		=	- A	
	(5)	Α	Α	
		÷	Α	
		_	Α	
		=	- A	
	(6)	Α	Α	
		X	Α	
	0	N/C/CE	0.	
		В	В	
		=	В	
	(7)	Α	Α	
		X	Α	
		В	В	
	0	N/C/CE	0.	
		С	С	
		=	A·C	

### **Key Chattering Protection**

(1) At time of key on : about 18.0ms, after key input. (f $\phi$  typ.)

(2) At time of key off : about 17.0ms, after completion of the operation (f $\phi$  typ.)

(3) Simultaneous Keying protection

If 2 or more keys are pressed simultaneously, any key input is not accepted.

### **MAXIMUM RATINGS**

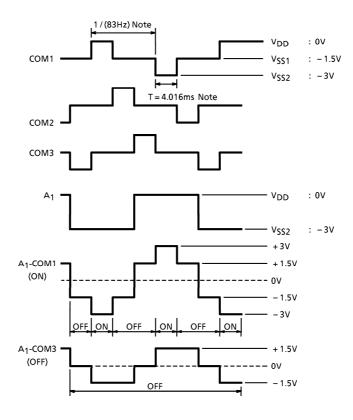
PARAMETER	SYMBOL	RATING	UNIT
Supply Voltage	V <sub>SS1</sub>	+ 0.3~ - 2.2	V
Input Voltage	VIN	+0.3~V <sub>DD1</sub> -0.3	٧
Operating Temperature	T <sub>opr</sub>	+0.0~40	°C
Storage Temperature	T <sub>sta</sub>	- 55~125	°C

# **ELECTRICAL CHARACTERISTICS** ( $V_{SS1} = -1.5V \pm 0.2V$ , $V_{SS2} = -3.0V \pm 4.0V$ , $V_{DD} = 0V$ , $Ta = 25^{\circ}C$ )

PARAMETER   SYMBOL   TEST   PIN   NAME   TEST CONDITION   MIN.   TYP.   MAX.	V V V V
Input "1"	V V
Input "1"	V
Output "1"  VOH  Segment, Common  Output "0"  VOL  Segment, Common  Output "1"  VOL  Segment, Common  VSS2 +0.2  VSS2  OUTput "1"  VOL  K1~K8, VSS1  VSS1  VSS1  VSS1  VSS1  VSS1  VSS1	V
Output "1"  VOH  Common  +0.2  VSS2  Output "0"  VOL  Segment, Common  Output "1"  VOL  VSS1  VSS1  VSS1  VSS1  VSS1  VSS1  VSS1	
Output "1" Vou _ K1~K8, _ Vss1 _ Vss1	V
	V
Output "0" VOL — K1~K6, RESET — 0 — -0.2	V
Output "1" ROH — Segment VOUT = VSS2 + 0.5V — — 70	kΩ
Output "0" Roy — Segment VoyT = -0.5V — — 70	kΩ
Output "1" ROH — Common VOUT = VSS2 + 0.5V — — 70	kΩ
Output "1" ROH — Common VOUT = VSS2 + 0.5V — 70  Output "0" ROL — Common VOUT = -0.5V — 70  RKH — K1~K8 VOUT = 0V 60 400 1500	kΩ
$\frac{8}{2}$ Pull Up $\frac{R_{KH}}{R_{KH}} - \frac{K_1 \sim K_8}{R_{KH}} = \frac{V_{OUT} = 0V}{R_{KH}} = \frac{60}{1500}$	kΩ
RESET   RESET   V <sub>OUT</sub> = 0V   180   300   420	kΩ
Output "0" $R_{OL}$ — $K_1 \sim K_6$ $V_{OUT} = -0.5V$ — — 10	kΩ
Supply Current 1 (On Display) $   V_{SS1} = -1.5V$ (No Keys) $ -2.2$ $-3.6$	μΑ
Supply Current 2 (Operation) $IDD2$ $ V_{SS1} = -1.2V$ (Peak OF A11 $9\sqrt{}$ ) $ -4.4$ $-6.6$	μΑ
Supply Current 3 $ DD3  -  VSS1  = -1.5V$ $-0.5 -2.0$	μΑ
Oscillating $f_{OSC}$ (WAIT) _ $V_{SS1} = On Display$ 5.4 9 12.6	kHz
Frequency         f <sub>osc</sub> (OP)         -1.5V         On Operating         10.8         18         25.2	kHz
Frame Frequency $f_F$ — $V_{SS1} = -1.5V (Wait)$ 50 83 117	Hz

### **WAVEFORMS FOR DISPLAY**

Display Device: FEM type LCD -3.0V, 1/2 bias, 1/3 duty dynamic system



Note :  $f \phi = 9kHz$ 

### **OTHERS**

- AUTO POWER OFF (Typ.) = 7MIN
- RESET Key
  - i) After releasing this key, the cpu is reset and display "0".

### PAD LOCATION TABLE

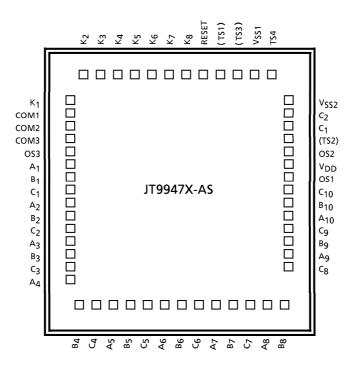
,		1
	m	1
1 / /	,,,,	

. , ,,,,,	PAD LOCATION TABLE			
No.	NAME	X POINT	Y POINT	
1	K <sub>1</sub>	- 1291	1093	
2	COM1	- 1291	896	
3	COM2	- 1291	744	
4	COM3	- 1291	592	
5	OS3	- 1291	441	
6	A <sub>1</sub>	- 1291	289	
7	B <sub>1</sub>	- 1291	137	
8	c <sub>1</sub>	- 1291	- 14	
9	A <sub>2</sub>	- 1291	<b>– 166</b>	
10	B <sub>2</sub>	- 1291	- 318	
11	C <sub>2</sub>	- 1291	<b>– 470</b>	
12	A <sub>3</sub>	- 1291	<b>–</b> 621	
13	В3	- 1291	<b>–</b> 773	
14	C <sub>3</sub>	- 1291	<b>- 925</b>	
15	A <sub>4</sub>	- 1291	<b>– 1076</b>	
16	В4	- 927	<b>–</b> 1249	
17	C <sub>4</sub>	<b>- 776</b>	<b>–</b> 1249	
18	A <sub>5</sub>	- 624	- 1249	
19	B <sub>5</sub>	<b>- 472</b>	- 1249	
20	C <sub>5</sub>	- 320	<b>–</b> 1249	
21	A <sub>6</sub>	<b>– 169</b>	- 1249	
22	В6	<b>– 17</b>	- 1249	
23	C <sub>6</sub>	135	- 1249	
24	A <sub>7</sub>	286	- 1249	
25	B <sub>7</sub>	438	<b>–</b> 1249	
26	C <sub>7</sub>	590	- 1249	
27	A8	741	<b>– 1249</b>	
28	В8	893	<b>– 1249</b>	
29	C <sub>8</sub>	1254	<b>–</b> 1077	

			(μπ)
No.	NAME	X POINT	Y POINT
30	A9	1254	<b>-</b> 925
31	В9	1254	<b>- 774</b>
32	C <sub>9</sub>	1254	<b>-</b> 622
33	A <sub>10</sub>	1254	<b>– 470</b>
34	B <sub>10</sub>	1254	<b>–</b> 319
35	C <sub>10</sub>	1254	<b>– 167</b>
36	OS1	1254	<b>–</b> 15
37	$V_{DD}$	1254	137
38	OS2	1254	288
39	*(TS2)	1254	489
40	C <sub>1</sub>	1254	697
41	C <sub>2</sub>	1254	898
42	$V_{SS2}$	1254	1100
43	TS4	949	1249
44	$V_{SS1}$	798	1249
45	*(TS3)	646	1249
46	*(TS1)	494	1249
47	RESET	343	1249
48	К8	191	1249
49	K <sub>7</sub>	39	1249
50	К <sub>6</sub>	<b>–</b> 112	1249
51	K <sub>5</sub>	<b>– 264</b>	1249
52	К4	<b>- 416</b>	1249
53	К3	- 568	1249
54	K <sub>2</sub>	<b>–</b> 719	1249

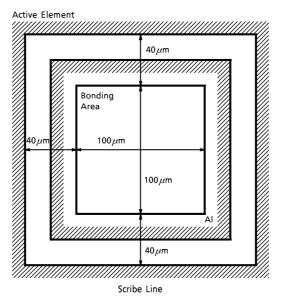
<sup>\*( )</sup> Do not connect.

### **CHIP LAYOUT**



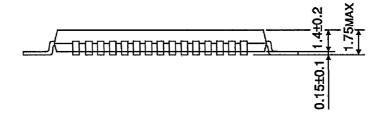
 $\begin{array}{lll} \mbox{Chip size} & : \ 3.04 \times 3.02 \ [\mbox{mm}] \\ \mbox{Chip thickness} & : \ 290 \pm 20 \ [\mbox{$\mu$m}] \\ \mbox{Substrate} & : \ \mbox{$V_{\rm DD}$} \end{array}$ 

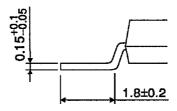
### PAD LAYOUT



PAD Pitch  $160 \mu m$ 

# OUTLINE DRAWING LQFP60-P-1414-0.80 Unit : mm 18.2±0.3 14.0±0.2 45 30 0.8 1.4TYP 1.4TYP 0.8 Unit : mm





Weight: 0.66g (Typ.)

### GENERAL SPECIFICATION FOR CALCULATOR LSI BARE CHIP

### 1. Purpose

This is to specify the quality standard for the integrated circuit produced by TOSHIBA CORPORATION (hereinafter referred as to VENDOR) to be delivered to PURCHASER.

### 2. Definition

This specification applies only to the calculator LSI bare chip produced by VENDOR and purchased by PURCHASER and defined the general specification items.

### 3. Priority of specifications

When the discrepancies or questions happen to the specifications and instructions provided by VENDOR, the priority shall be ranked as follows.

- Individual specification for the calculator LSI bare chip.
   (Both PURCHASER and VENDOR are confirmed by the special sheets.)
- 2) General specifications for the calculator LSI bare chip.
- 3) Other related specifications and standards.

### 4. Characteristics

To be shown in the individual specification sheets.

The individual specification shall consist of the following 4 items in principle.

- 1) Rated specifications.
- 2) Electrical characteristics.
- 3) Pin configuration & mechanical dimensions.
- 4) Others.

### 5. Inspection of product for delivery

### 5.1 Inspection lot

- a) Inspection lot shall consist of products produced by same material under same design, through same production process, and same facilities and assured same quality by same quality assurance method, and lot number shall be put on all trays to be able to trace the lot history.
- b) The quantity of products per Inspection lot shall consist of all the same VENDOR's lot number.

### 5.2 Sampling plan

Statistical sampling and inspection shall be in accordance with MIL-STD-105D single sampling plans for normal inspections, general inspection level  $\, {
m II} \, .$ 

The acceptable quality level (AQL) shall be specified in following table :

TEST ITEM	AQL (%)
Electrical	2.5
Visual	4.0

### 5.3 Electrical criteria

Criteria of Electrical Characteristics are prescribed in Attachment-1.

### 5.4 Visual criteria

Visual Criteria are prescribed in Attachment-2.

### 6. Incoming inspection

### 6.1 General

- a) PURCHASER's incoming inspection should be done within 15 days after PURCHASER receives the quantity of products in principle.
- b) PURCHASER shall report the results of incoming inspection to VENDOR and provide VENDOR with detailed data in failure rate and items regarding VENDOR's lot number respectively, if VENDOR demands the report from PURCHASER.

### 6.2 Inspection procedure

PURCHASER should do his incoming inspection according to the following procedure.

- a) First: Visual inspection should be done.
- b) Next: Electrical and other inspection should be done under condition with bare chip before going into PURCHASER's process.

### 7. Treatment for defective lot and products

Regarding the defective lot and defective products which are found through PURCHASER's incoming inspection, PURCHASER can be returned to VENDOR with detailed description on failures concerned.

However, if VENDOR cannot receive the defective items within 30 days after PURCHASER's incoming inspection, VENDOR should be able to make no reference to the defective problem.

- 8. Packing and labeling
  - a) Dice shall be placed in die tray with the top metalization facting up in order.
  - b) In principle, a pile consists of 5 trays and several piles are packed in a package. These piles and packages are indicated with printed labels as shown below.

Date					
Name					
Lot No.					
Net					
TOSHIBA					
MADE IN JAPAN					

c) PURCHASER shall return these packing materials to VENDOR on VENDOR's demand.

### 9. Storage criteria

Solid state chips, unlike packaged devices, are non-hermetic devices normally fragile and small in physical size, and therefore, require special handling considerations as follows:

9.1 Chips must be stored under proper conditions to insure that they are not subjected to a moist and/or contaminated atmosphere that alter their electrical, physical, or mechanical characteristics.

After the shipping container is opened, the chips must be stored under the following conditions:

- A. Storage temperature, 40°C max.
- B. Relative humidity, 50% max.
- C. Clean, dust-free environment.
- 9.2 The user must exercise proper care when handling chips or wafers to prevent even the slightest physical damage to the chip.
- 9.3 During mounting and lead bounding of chips the user must use proper assembly techniques to obtain proper electrical, thermal, and mechanical performance.
- 9.4 After the chip has been mounted and bounded, any necessary procedure must be followed by the user to insure that these non-hermetic chips are not subjected to moist or contaminated atmosphere which might cause the development of electrical conductive paths across the relatively small insulating surfaces.
  - In addition, proper consideration must be given to the protection of these devices from other harmful environments which could conceivably adversely affect their proper performance.

### 10. Handling criteria

The user should find the following suggested precautions helpful in handling chips. In any event, because of the extremely small size and fragile nature of chips, care should be taken in handling these devices.

### 10.1 Grounding

- a) Bonders, pellet pickup tools, table tops, trim and form tools, sealing equipment, and other equipment used in chip handling should be properly grounded.
- b) Operator should be properly grounded.

### 10.2 In-process handling

- a) Assemblies or subassemblies of chips should be transported and stored in conductive carriers
- b) All external leads of the assemblies or subassemblies should be shorted together.

### VISUAL INSPECTION CRITERIA

- 1. Visual inspection magnification shall be 40  $\times$  in principle.
- 2. Defects defined:
  - 2.1 Thickness

See the technical data sheet.

2.2 Chip and crack

A die shall be rejected if:

a) Any crack of chip extends greater than  $35\mu\mathrm{m}$  in length into the inside of the scribble line. (see Fig.1)

### 2.3 Metallization

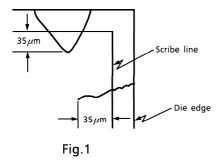
A die shall be rejected if:

- a) More than 25% of the designed area of the metallization is missing at any bonding pad.
- b) There is a short or break which affects electrical characteristics in any lead pattern. (see Fig.2)
- 2.4 Glass protection coat

A die shall be rejected if:

a) It exhibits glass protection coat which covers more than 25% of any active bonding pad.

- 2.5 Attached foreign material
  - A die shall be rejected if:
  - a) A die is covered by stains or attached foreign material which size is more than 5 times as large as a bonding pad area.
  - b) It exhibits residual ink, stains or attached foreign material which covers more than 20% of any active bonding pad. (see Fig.3)
- 2.6 Others
  - A die shall be rejected if:
  - a) There have no evident probed impression on the bonding pads.
  - b) A inked die, defective die, is intermized.
- 3. Limit samples should be fized, if necessary.



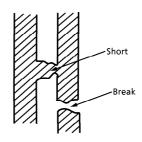
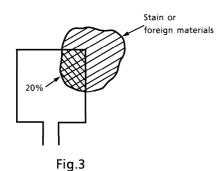
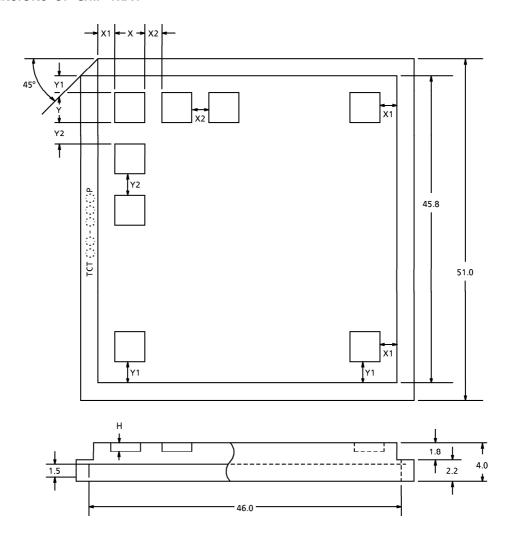


Fig.2 Lead pattern



### **OUTSIDE DIMENSIONS OF CHIP TRAY**



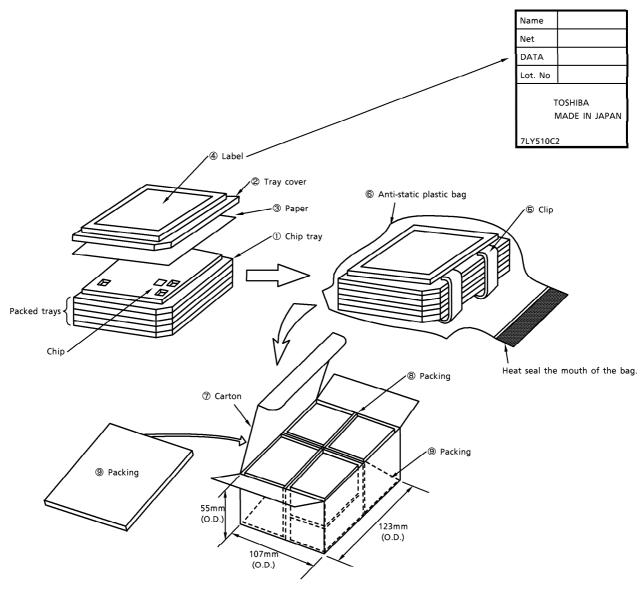
Unit : mm

CHIP NAME	TRAY NAME	Х	Υ	(H)	No. OF POCKETS	X1	X2	Y1	Y2
JT9947X-AS	TCT33-060P	3.30	3.30	0.60	10 × 10 (100)	1.900	1.000	1.900	1.000

### Tray material:

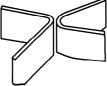
Carbon-containing polypropylene

### **PACKING METHOD-1**

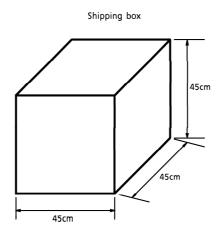


Place eight bags of chip trays in each carton box ⑦. Lay one sheet of packing ⑨ (7UF44F) before closing the lid of the cart box. (See the diagram above.)

Prepare packing ® by cutting 7UF44F into halves and folding each in half as shown below; use them as inner partitions.



### **PACKING METHOD-2**



• Inner box : Containing 20 boxes

Weight : Approx. 15kg (including packing material)
 Material : Corrugated cardboard

• IC contents :  $36 \times 5 \times 8 \times 20 = 28.8$ kpcs.